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PATENT  
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**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

APPLICANTS : John F. Zumkehr  
SERIAL NO. : 10/025,760  
FILED : December 26, 2001  
FOR : METHOD AND CIRCUIT TO IMPLEMENT DOUBLE  
DATA RATE TESTING  
GROUP ART UNIT : 2133  
EXAMINER : John J. Tabone, Jr.

**RECEIVED**

**NOV 16 2004**

Technology Center 2100

HON. COMMISSIONER  
FOR PATENTS  
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**AMENDMENT**

SIR:

The following amendment and remarks below are respectfully submitted in  
response to the Office Action dated May 7, 2004.